

POWER MONITORING AND SWITCHING CONTROLLER FOR 3.3-V SRAM

FEATURES

- Power Monitoring and Switching for Non-Volatile Control of SRAMs
- Input Decoder Allows Control of 1 or 2 Banks of SRAM
- Write-Protect Control
- 3-V Primary Cell Input
- 3.3-V Operation
- Reset Output for System Power-On Reset
- Less than 20-ns Chip Enable Propagation Delay
- Small 16-Lead TSSOP Package

APPLICATIONS

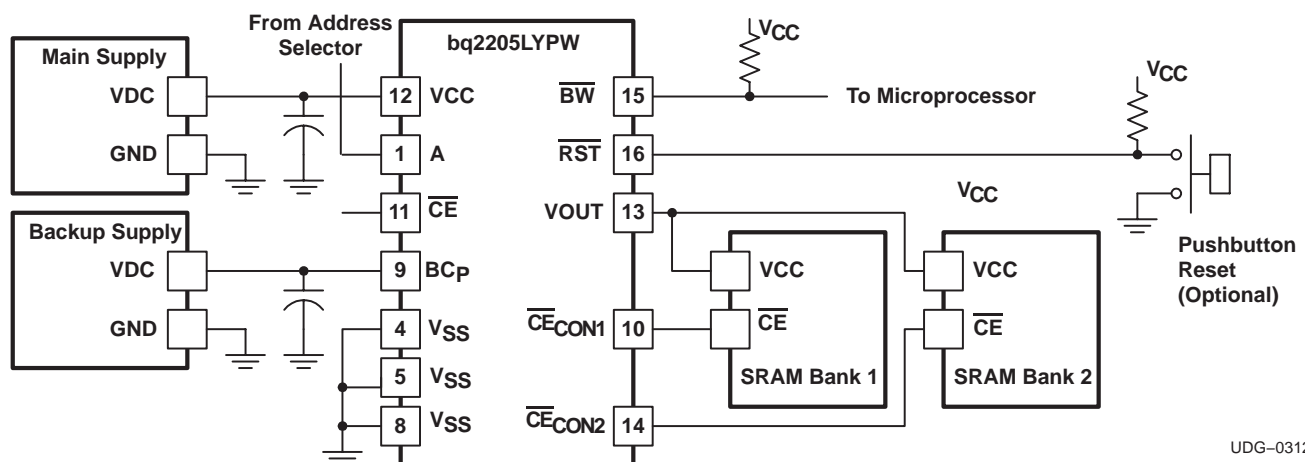
- NVSRAM Modules
- Point-of-Sale Systems
- Facsimile, Printers and Photocopiers
- Internet Appliances
- Servers
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DESCRIPTION

The CMOS bq2205 SRAM non-volatile controller with reset provides all the necessary functions for converting one or two banks of standard CMOS SRAM into non-volatile read/write memory.

A precision comparator monitors the 3.3-V VCC input for an out-of-tolerance condition. When out-of-tolerance is detected, the two conditioned chip-enable outputs are forced inactive to write-protect both banks of SRAM.

Power for the external SRAMs, VOUT, is switched from the VCC supply to the battery-backup supply as VCC decays. On a subsequent power-up, the VOUT supply is automatically switched from the backup supply to the VCC supply. The external SRAMs are write-protected until a power-valid condition exists. The reset output provides power-fail and power-on resets for the system. During power-valid operation, the input decoder, A, selects one of two banks of SRAM.



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ORDERING INFORMATION

T_A	OPERATION	PART NUMBER ⁽¹⁾	SYMBOL
-20°C to 70°C	3.3 V	bq2205LYPW	bq2205LY

(1) The PW package is available taped and reeled. Add an R suffix to the device type (i.e. bq2205LYPWR) to order quantities of 2,000 devices per reel.

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range unless otherwise noted⁽²⁾

		bq2205LY	UNIT
Input voltage range	V_{CC} , (wrt V_{SS})	-0.3 to 6.0	V
	BC_P , (wrt V_{SS})	-0.3 to 4.5	
	all other pins, (wrt V_{SS})	-0.3 to $V_{CC} + 0.3$	
Operating temperature range, T_A		-20 to 70	°C
Storage temperature, T_{stg}		-55 to 125	
Temperature under bias, T_{Jbias}		-40 to 85	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds		300	

(2) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS

	MIN	MAX	UNIT
Supply voltage, V_{CC}	3.0	3.6	V
Supply voltage from backup cell, V_{BC}	2.0	4.0	
Low-level input voltage, V_{IL}	-0.3	0.8	
High-level input voltage, V_{IH}	2.2	$V_{CC} + 0.3$	
\overline{RST} low-level input voltage, V_{IL}	-0.3	0.4	
\overline{RST} high-level input voltage, V_{IH}	2.2	$V_{CC} + 0.3$	
Operating temperature range, T_A	-20	70	°C

ELECTRICAL CHARACTERISTICS(T_A = 25°C, V_{CC}(min) ≤ V_{CC} ≤ V_{CC}(max) unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
VCC supply current, I _{CC} (VCC)	V _{BC} > V _{CC} (MIN) CE = low CECONX = 0 mA		210	500	μA
Backup Battery Supply Current, I _{CC} (BC)	V _{BC} > V _{BC} (MIN), V _{CC} = 0 V CE = low CECONX = 0 mA		50	150	nA
Output voltage (VOUT)	I(VOUT) = 80 mA, V _{CC} > V(SO)	V _{CC} -0.3			V
	I(VOUT) = 100 μA, V _{CC} < V(SO)	V _{BC} -0.3			
Power fail detect voltage, V _{PFD}		2.85	2.9	2.95	
Supply switch-over voltage, V _{SO}	V _{BC} > V(PFD)		V _{PFD}		
	V _{BC} < V(PFD)		V _{BC}		
RST output voltage	I(RST) = 1 mA			0.4	V
BW output voltage	I(BW) = 1 mA			0.4	
Input leakage current on A and CE pins		-1		1	
V _{oh} CE _{con1,2}	I _{oh} = 0.5 mA		2.4		V
V _{ol} CE _{con1,2}	I _{ol} = 2.0 mA		0.4		
Battery warning level V _{BW}	(1)			0.677xV _{CC}	
Capacitance					
Output capacitance	VOUT = 0 V			7	pF
Input capacitance	VOUT = 0 V			5	
Power-Down and Power-Up Timing, Refer to Figure 1 through 3					
VCC slew rate fall time, t _F	3.0 V to 0.0 V	300			μs
VCC slew rate rise time, t _R	V _{SO} to V _{PFD} (max)	100			
V _{PFD} to RST active, t _{RST} (reset active timeout period)		30		85	ms
Chip-enable recovery time, t _{CER}	(2)	30		85	
Chip-enable propagation delay time to external SRAM, t _{CED}	See Figure 2		15	25	ns
Push-button low time, t _{PBL}	RST pin		1		μs

(1) Battery warning level is detected on power up and the BW pin is latched at t_{CER} time after V_{CC} passes through V_{PFD} on power up.(2) Time during which external SRAM is write protected after V_{CC} passes through V_{PFD} on power up.

AC TEST CONDITIONS, INPUT PULSE LEVELS $0\text{ V} \leq V_{IN} \leq 3\text{ V}$, $t_R = t_F = 5\text{ NS}$

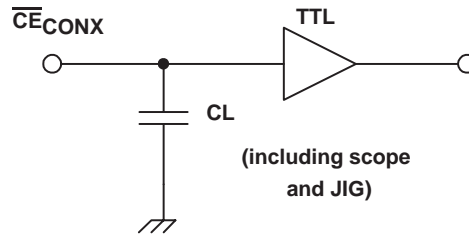


Figure 1. Output Load

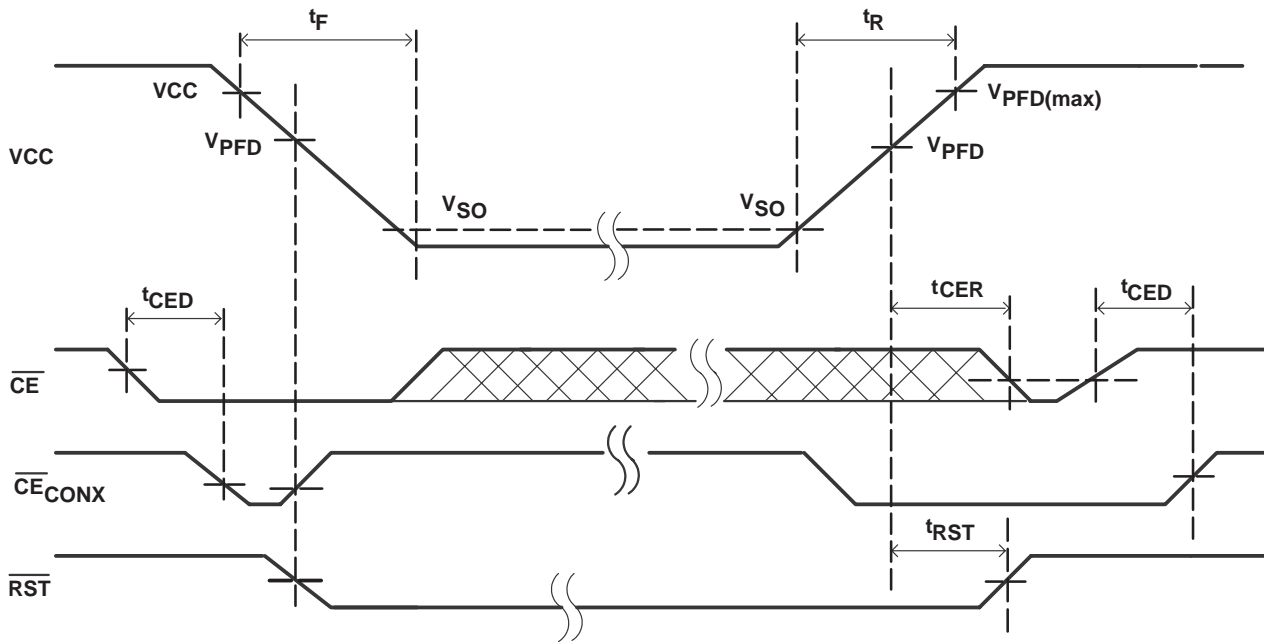


Figure 2. Power-Down/Power-Up Timing Diagram

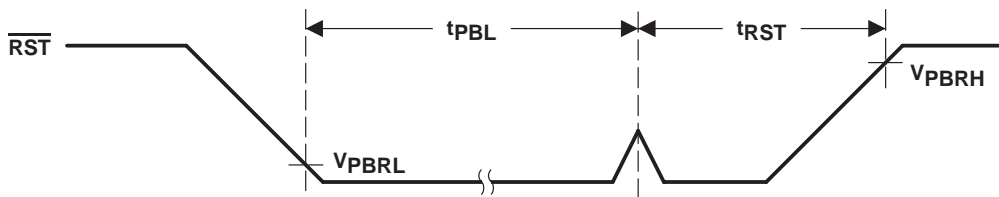
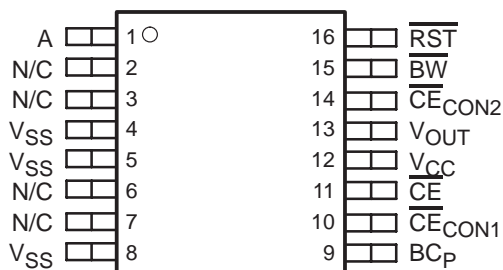


Figure 3. Push-Button Reset Timing

TERMINAL FUNCTIONS

NAME	TERMINAL	I/O	DESCRIPTION
	bq2205LY		
A	1	I	SRAM bank select input
BC _P	9	I	Backup supply input
$\overline{\text{BW}}$	15	O	Battery warning output (open-drain)
$\overline{\text{CE}}$	11	I	Chip enable input (active low)
$\overline{\text{CECON1}}$	10	O	Conditioned chip enable output 1
$\overline{\text{CECON2}}$	14	O	Conditioned chip enable output 2
N/C	2, 3, 6, 7	–	No connect. These pins must be left floating.
$\overline{\text{RST}}$	16	O	Power-up reset to system CPU output (open-drain)
V _{CC}	12	I	Main supply input
V _{OUT}	13	O	SRAM supply output
V _{SS}	4, 5, 8	–	Ground input

PW PACKAGE
(TOP VIEW)



N/C no connection

FUNCTIONAL DESCRIPTION

Two banks of CMOS static RAM can be battery-backed using the VOUT and conditioned chip-enable output pins from the bq2205. As the voltage input VCC slews down during a power failure, the two-conditioned chip enable outputs, \overline{CE}_{CON1} and \overline{CE}_{CON2} , are forced inactive independent of the chip enable input, \overline{CE} . This activity unconditionally write-protects the external SRAM as VCC falls to an out-of-tolerance threshold V_{PFD} . As the supply continues to fall past V_{PFD} , an internal switching device forces VOUT to the backup energy source. \overline{CE}_{CON1} and \overline{CE}_{CON2} are held high by the VOUT energy source.

During power-up, VOUT is switched back to the 3.3-V supply as VCC rises above the backup cell input voltage sourcing VOUT. Outputs \overline{CE}_{CON1} and \overline{CE}_{CON2} are held inactive for time t_{CER} after the power supply has reached V_{PFD} , independent of the \overline{CE} input, to allow for processor stabilization.

During power-valid operation, the \overline{CE} input is passed through to one of the two \overline{CE}_{CONx} outputs with a propagation delay of less than t_{CED} . The \overline{CE} input is output on one of the two \overline{CE}_{CONx} output pins; depending on the level of bank select input A. See truth table below.

Table 1. Truth Table

INPUT		OUTPUT	
\overline{CE}	A	\overline{CE}_{CON1}	\overline{CE}_{CON2}
H	x	H	H
L	L	L	H
L	H	H	L

Bank select input A is usually tied to a high-order address pin so that a large nonvolatile memory can be designed using lower-density memory devices. Non-volatility and decoding are achieved by hardware hookup as shown in the application diagram.

The \overline{RST} output can be used as the power-on reset for a microprocessor. Access to the external RAM may begin when \overline{RST} returns inactive.

BATTERY BACKUP INPUT

Backup energy source, BC_P input is provided on the bq2205 for use with an external primary cell. The primary cell input is designed to accept any 3-V primary battery (non-rechargeable), typically some type of lithium chemistry.

Power-Down and Power-Up Cycle

The bq2205 continuously monitors VCC for out-of-tolerance. During a power failure, when VCC falls below V_{PFD} , the bq2205 write-protects the external SRAM. The power source is switched to BC_P when V_{CC} is less than V_{PFD} and BC_P is greater than V_{PFD} , or when V_{CC} is less than BC_P and BC_P is less than V_{PFD} . When VCC is above V_{PFD} , the power source is V_{CC} . Write-protection continues for t_{CER} time after VCC rises above V_{PFD} .

An external CMOS static RAM is battery-backed using the VOUT and chip enable output pins from the bq2205. As the voltage input V_{CC} slews down during a power failure, the chip enable output, \overline{CE}_{CONx} , is forced inactive independent of the chip enable input \overline{CE} .

As the supply continues to fall past V_{PFD} , an internal switching device forces VOUT to the external backup energy source. \overline{CE}_{CONx} is held high by the VOUT energy source.

FUNCTIONAL DESCRIPTION

During power up, VOUT is switched back to the main supply as VCC rises above the backup cell input voltage sourcing VOUT. If $V_{PFD} < BC_P$ on the bq2205 the switch to the main supply occurs at V_{PFD} . \overline{CE}_{CONx} is held inactive for time t_{CER} after the power supply has reached V_{PFD} , independent of the \overline{CE} input, to allow for processor stabilization.

Power-On Reset

The bq2205 provides a power-on reset, which pulls the \overline{RST} pin low on power down and remains low on power up for t_{RST} after V_{CC} passes V_{PFD} . With valid battery voltage on BC_P , \overline{RST} remains valid for $V_{CC} = V_{SS}$. The pull-up resistor on this pin should not exceed 10 k Ω if a push button reset is used.

Battery Low Warning

The bq2205 checks the battery voltage on power-up. The threshold for the battery warning comparator is V_{BW} , and a low level is sensed after power valid on each power up and latched after t_{CER} time. The latched value is presented at \overline{BW} pin where a low indicates a low battery.

APPLICATION INFORMATION

PCB LAYOUT INFORMATION

It is important to pay special attention to the PCB layout. The following provides some guidelines:

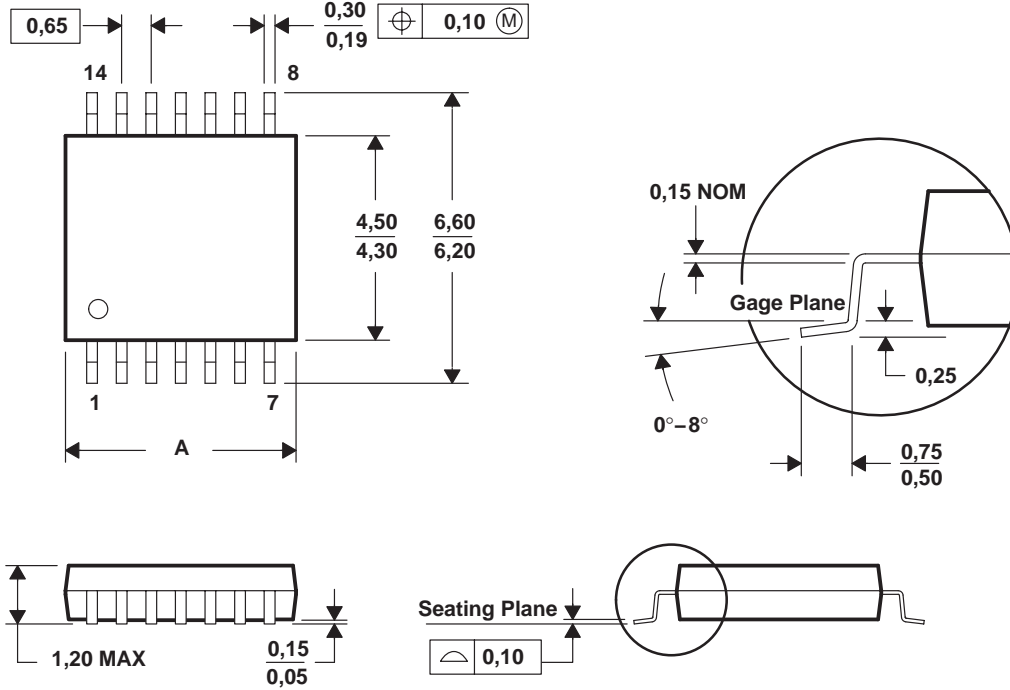
- To obtain optimal performance, the decoupling capacitor from input terminals to V_{SS} should be placed as close as possible to the bq2205, with short trace runs to both signal and V_{SS} pins.
- All low-current V_{SS} connections should be kept separate from the high-current paths from the inputs supplies. Use a single-point ground technique incorporating both the small signal ground path and the power ground path.

MECHANICAL DATA

PW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



DIM \ PINS **	8	14	16	20	24	28
A MAX	3,10	5,10	5,10	6,60	7,90	9,80
A MIN	2,90	4,90	4,90	6,40	7,70	9,60

4040064/F 01/97

- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
 D. Falls within JEDEC MO-153

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
BQ2205LYPW	Last Time Buy	Production	TSSOP (PW) 16	90 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-20 to 70	2205Y
BQ2205LYPW.B	Last Time Buy	Production	TSSOP (PW) 16	90 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-20 to 70	2205Y
BQ2205LYPWR	Last Time Buy	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-20 to 70	2205Y
BQ2205LYPWR.B	Last Time Buy	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-20 to 70	2205Y

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ2205LYPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ2205LYPWR	TSSOP	PW	16	2000	350.0	350.0	43.0

TUBE


*All dimensions are nominal

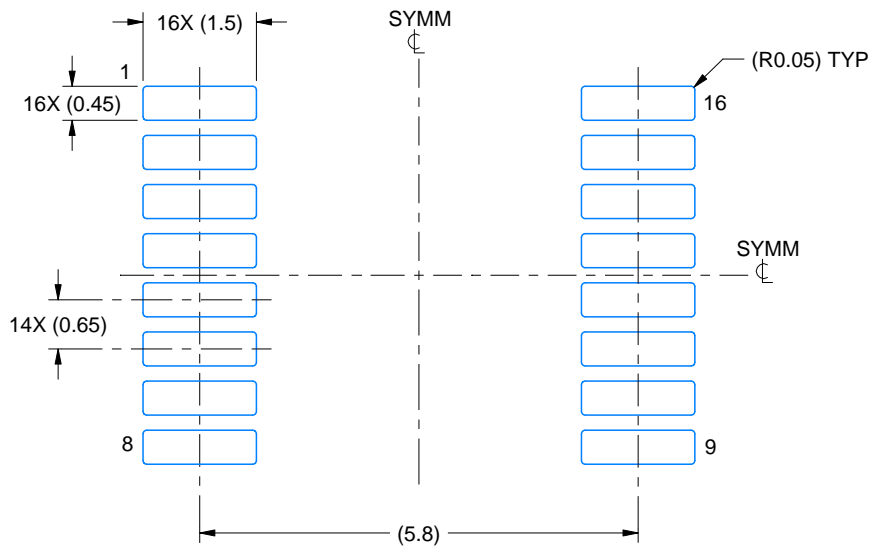
Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
BQ2205LYPW	PW	TSSOP	16	90	530	10.2	3600	3.5
BQ2205LYPW.B	PW	TSSOP	16	90	530	10.2	3600	3.5

EXAMPLE BOARD LAYOUT

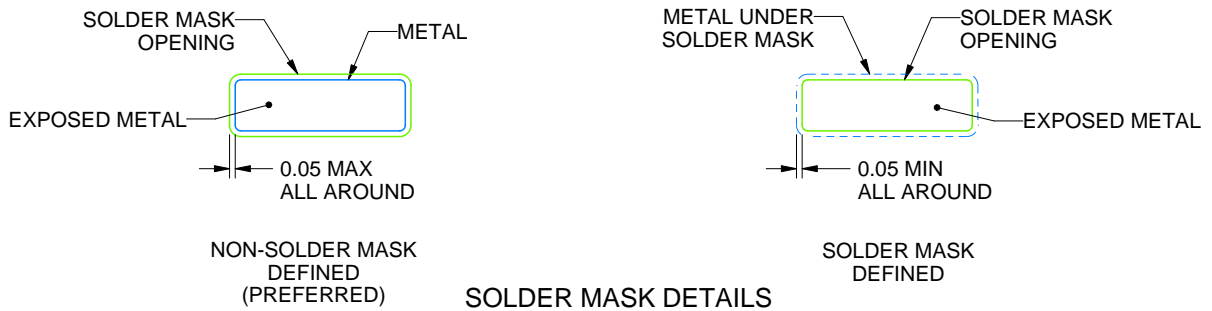
PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



SOLDER MASK DETAILS

4220204/B 12/2023

NOTES: (continued)

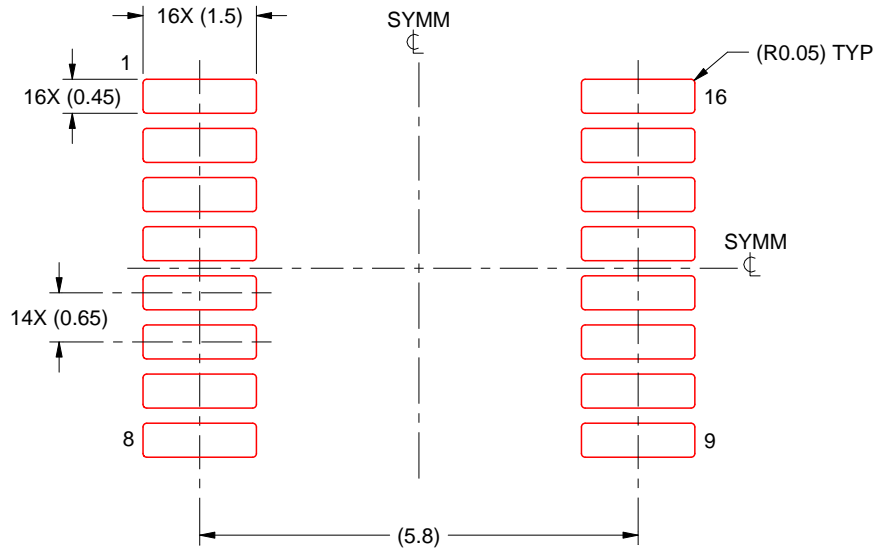
- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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